



## 3.8V TO 32V INPUT, 3A LOW IQ SYNCHRONOUS BUCK WITH ENHANCED EMI REDUCTION

### **Description**

The AP63300/AP63301 is a 3A, synchronous buck converter with a wide input voltage range of 3.8V to 32V. The device fully integrates a  $75m\Omega$  high-side power MOSFET and a  $40m\Omega$  low-side power MOSFET to provide high-efficiency step-down DC-DC conversion.

The AP63300/AP63301 device is easily used by minimizing the external component count due to its adoption of peak current mode control along with its integrated loop compensation network.

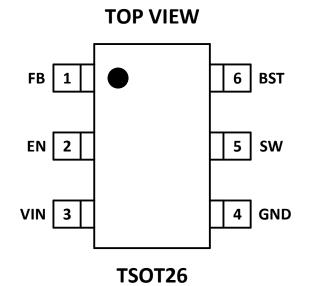
The AP63300/AP63301 design is optimized for Electromagnetic Interference (EMI) reduction. The device has a proprietary gate driver scheme to resist switching node ringing without sacrificing MOSFET turn-on and turn-off times, which reduces high-frequency radiated EMI noise caused by MOSFET switching. AP63300 also features Frequency Spread Spectrum (FSS) with a switching frequency jitter of ±6%, which reduces EMI by not allowing emitted energy to stay in any one frequency for a significant period of time.

The device is available in a TSOT26 package.

#### **Features**

- VIN 3.8V to 32V
- 3A Continuous Output Current
- 0.8V ± 1% Reference Voltage
- 22µA Low Quiescent Current (Pulse Frequency Modulation)
- 500kHz Switching Frequency
- Supports Pulse Frequency Modulation (PFM)
  - o AP63300
  - Up to 88% Efficiency at 5mA Light Load
- Pulse Width Modulation (PWM) Regardless of Output Load
  - o AP63301
- Proprietary Gate Driver Design for Best EMI Reduction
- Frequency Spread Spectrum (FSS) to Reduce EMI
  - o AP63300
- Low-Dropout (LDO) Mode
- Precision Enable Threshold to Adjust UVLO
- Protection Circuitry
  - Undervoltage Lockout (UVLO)
  - Output Overvoltage Protection (OVP)
  - o Cycle-by-Cycle Peak Current Limit
  - Thermal Shutdown
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

## **Pin Assignments**



## **Applications**

- 5V, 12V, and 24V Distributed Power Bus Supplies
- Flat Screen TV Sets and Monitors
- Power Tools and Laser Printers
- White Goods and Small Home Appliances
- FPGA, DSP, and ASIC Supplies
- Home Audio
- Network Systems
- Gaming Consoles
- Consumer Electronics
- · General Purpose Point of Load

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.



# **Typical Application Circuit**

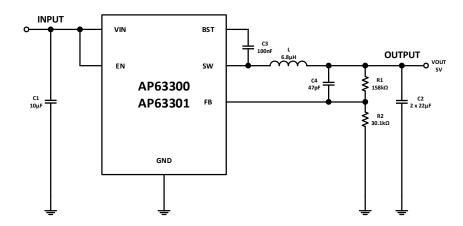


Figure 1. Typical Application Circuit

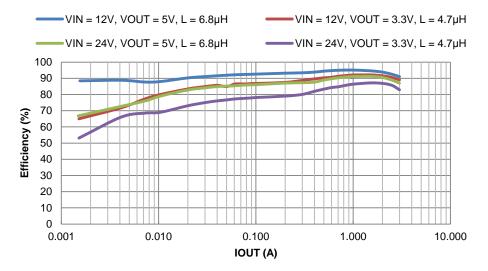


Figure 2. AP63300 Efficiency vs. Output Current

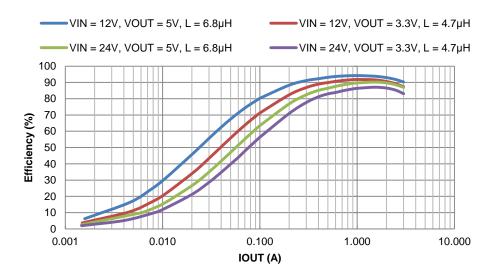


Figure 3. AP63301 Efficiency vs. Output Current



# **Pin Descriptions**

Pin Name	Pin Number	Function
FB	1	Feedback sensing terminal for the output voltage. Connect this pin to the resistive divider of the output.  See <b>Setting the Output Voltage</b> section for more details.
EN		Enable Input. EN is a digital input that turns the regulator on or off. Drive EN high to turn on the regulator and low to turn it off. Connect to VIN or leave floating for automatic startup. The EN has a precision threshold of 1.18V for programing the UVLO. See <b>Enable</b> section for more details.
VIN	3	Power Input. VIN supplies the power to the IC as well as the step-down converter power MOSFETs. Drive VIN with a 3.8V to 32V power source. Bypass VIN to GND with a suitably large capacitor to eliminate noise due to the switching of the IC. See <b>Input Capacitor</b> section for more details.
GND	4	Power Ground.
SW	5	Power Switching Output. SW is the switching node that supplies power to the output. Connect the output LC filter from SW to the output load.
BST	6	High-Side Gate Drive Boost Input. BST supplies the drive for the high-side N-Channel power MOSFET. A 100nF capacitor is recommended from BST to SW to power the high-side driver.



# **Functional Block Diagram**

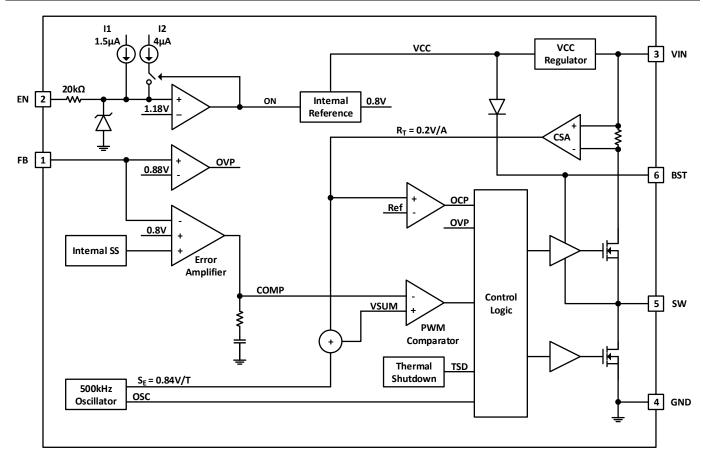


Figure 4. Functional Block Diagram



## Absolute Maximum Ratings (Note 4) (At T<sub>A</sub> = +25°C, unless otherwise specified.)

Symbol	Parameter	Rating	Unit	
VIN	Supply Pin Voltage	-0.3 to +35.0 (DC)	V	
VIIN	Supply Fill Voltage	-0.3 to +40.0 (400ms)	v	
V <sub>FB</sub>	Feedback Pin Voltage	-0.3V to +6.0	V	
V <sub>EN</sub>	Enable/UVLO Pin Voltage	-0.3 to +35.0	V	
Vsw	Switch Pin Voltage	-0.3 to VIN + 0.3 (DC)	V	
VSW	Switch Fill Voltage	-2.5 to VIN + 2.0 (20ns)	V	
$V_{BST}$	Bootstrap Pin Voltage	V <sub>SW</sub> - 0.3 to V <sub>SW</sub> + 6.0	V	
T <sub>ST</sub>	Storage Temperature	-65 to +150	°C	
TJ	Junction Temperature	+160	°C	
T <sub>L</sub>	Lead Temperature	+260	°C	
ESD Susceptibility (Note 5)				
НВМ	Human Body Model	2000	V	
CDM	Charged Device Model	1000	V	

Notes:

## Thermal Resistance (Note 6)

Symbol	Parameter	Rat	ing	Unit
$\theta_{JA}$	Junction to Ambient	TSOT26	89	°C/W
θЈС	Junction to Case	TSOT26	39	°C/W

Note:

## Recommended Operating Conditions (Note 7) (At T<sub>A</sub> = +25°C, unless otherwise specified.)

Symbol	Parameter	Min	Max	Unit
VIN	Supply Voltage	3.8	32	V
VOUT	Output Voltage	0.8	31	V
T <sub>A</sub>	Operating Ambient Temperature Range	-40	+85	°C
TJ	Operating Junction Temperature Range	-40	+125	°C

Note:

 $\label{eq:commended} \textbf{7. The device function is not guaranteed outside of the recommended operating conditions.}$ 

<sup>4.</sup> Stresses greater than the **Absolute Maximum Ratings** specified above may cause permanent damage to the device. These are stress ratings only; functional operation of the device at these or any other conditions exceeding those indicated in this specification is not implied. Device reliability may be affected by exposure to absolute maximum rating conditions for extended periods of time.

<sup>5.</sup> Semiconductor devices are ESD sensitive and may be damaged by exposure to ESD events. Suitable ESD precautions should be taken when handling and transporting these devices.

<sup>6.</sup> Test condition for TSOT26: Device mounted on FR-4 substrate, single-layer PC board, 2oz copper, with minimum recommended pad layout.



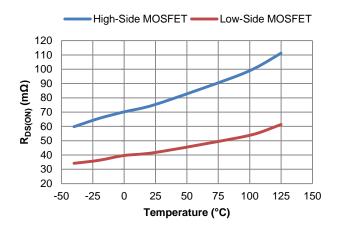
**Electrical Characteristics** (At  $T_A = +25$ °C, VIN = 12V, unless otherwise specified. Min/Max limits apply across the recommended ambient temperature range, -40°C to +85°C, and input voltage range, 3.8V to 32V, unless otherwise specified.)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
I <sub>SHDN</sub>	Shutdown Supply Current	V <sub>EN</sub> = 0V	_	1	3	μΑ
	Supply Current (Ovicesent)	AP63300: $V_{EN} = Floating, V_{FB} = 1.0V$	-	22	_	μА
lQ	Supply Current (Quiescent)	AP63301: $V_{EN} = Floating, V_{FB} = 1.0V$	_	280	_	μΑ
UVLO	VIN Undervoltage Rising Threshold	_	-	3.5	3.7	V
OVLO	VIN Undervoltage Hysteresis	_	-	440	_	mV
R <sub>DS(ON)1</sub>	High-Side Power MOSFET On-Resistance (Note 8)	_	_	75	_	mΩ
R <sub>DS(ON)2</sub>	Low-Side Power MOSFET On-Resistance (Note 8)	_	_	40	_	mΩ
I <sub>PEAK_LIMIT</sub>	HS Peak Current Limit (Note 8)	_	4.1	4.5	4.9	Α
I <sub>VALLEY_LIMIT</sub>	LS Valley Current Limit (Note 8)	_	_	4.0	_	Α
I <sub>PFMPK</sub>	PFM Peak Current Limit	_	_	930	_	mA
I <sub>ZC</sub>	Zero Cross Current Threshold	_	_	60	_	mA
f <sub>SW</sub>	Oscillator Frequency	_	450	500	550	kHz
ton_min	Minimum On-Time	_	_	80	_	ns
$V_{FB}$	Feedback Voltage	ССМ	792	800	808	mV
V <sub>EN_H</sub>	EN Logic High	_	_	1.18	1.25	V
V <sub>EN_L</sub>	EN Logic Low	_	1.03	1.09	_	V
1	EN locut Current	V <sub>EN</sub> = 1.5V	_	5.5	_	μΑ
I <sub>EN</sub>	EN Input Current	V <sub>EN</sub> = 1V	1	1.5	2	μΑ
t <sub>SS</sub>	Soft-Start Time	_	_	4	_	ms
T <sub>SD</sub>	Thermal Shutdown Threshold (Note 8)	_	_	160	_	°C
T <sub>Hys</sub>	Thermal Shutdown Hysteresis (Note 8)	_	_	25	_	°C

Note: 8. Compliance to the datasheet limits is assured by one or more methods: production test, characterization, and/or design.



**Typical Performance Characteristics** (AP63300/AP63301 at T<sub>A</sub> = +25°C, VIN = 12V, VOUT = 5V, unless otherwise specified.)



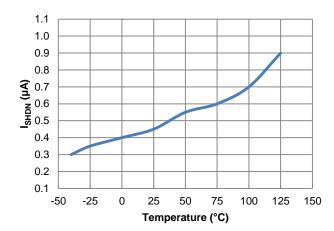


Figure 5. Power MOSFET R<sub>DS(ON)</sub> vs. Temperature

Figure 6. I<sub>SHDN</sub> vs. Temperature

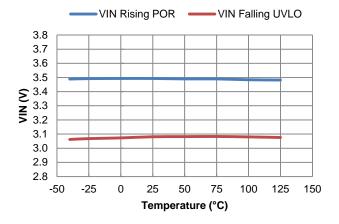
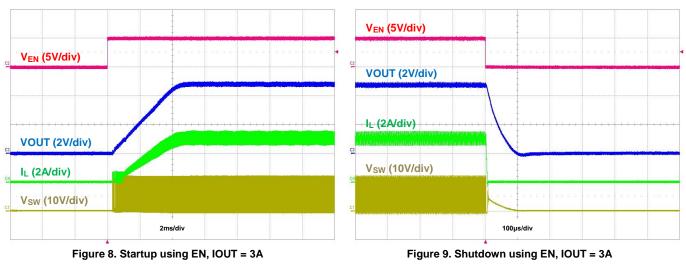


Figure 7. VIN Power-On Reset and UVLO vs. Temperature



**Typical Performance Characteristics** (AP63300/AP63301 at T<sub>A</sub> = +25°C, VIN = 12V, VOUT = 5V, unless otherwise specified.) (continued)



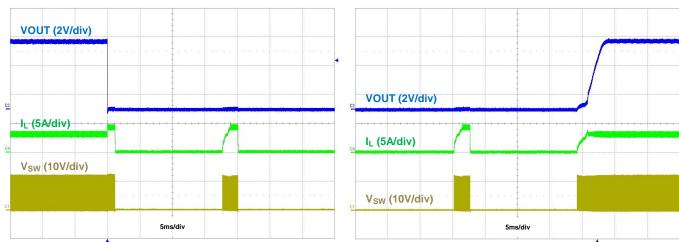


Figure 10. Output Short Protection, IOUT = 3A

Figure 11. Output Short Recovery, IOUT = 3A



# Typical Performance Characteristics (AP63300 at T<sub>A</sub> = +25°C, VIN = 12V, VOUT = 5V, unless otherwise specified.)

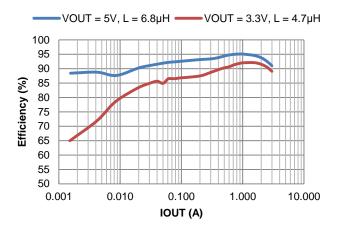


Figure 12. Efficiency vs. Output Current, VIN = 12V

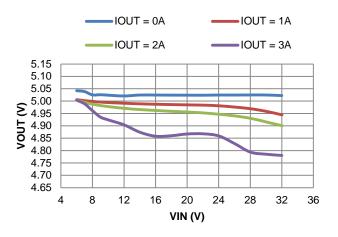


Figure 14. Line Regulation

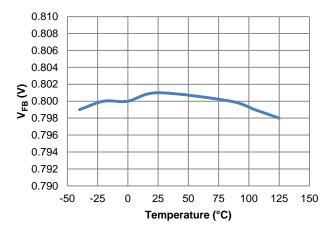


Figure 16. Feedback Voltage vs. Temperature

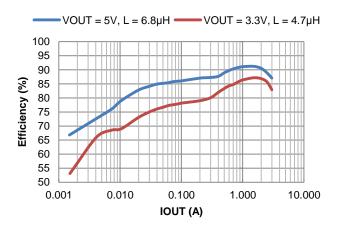


Figure 13. Efficiency vs. Output Current, VIN = 24V

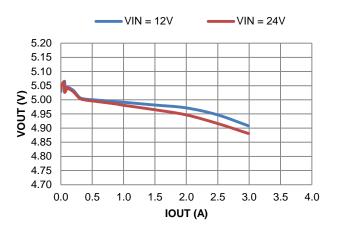


Figure 15. Load Regulation

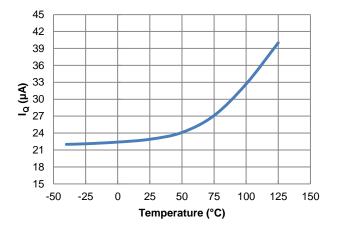


Figure 17. IQ vs. Temperature



# **Typical Performance Characteristics** (AP63300 at $T_A = +25$ °C, VIN = 12V, VOUT = 5V, unless otherwise specified.) (continued)

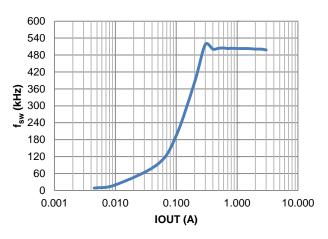


Figure 18. f<sub>sw</sub> vs. Load

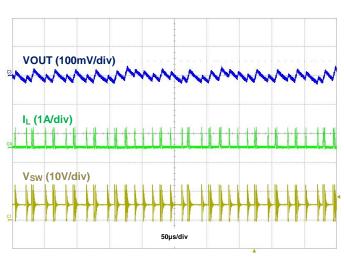


Figure 19. Output Voltage Ripple, IOUT = 50mA

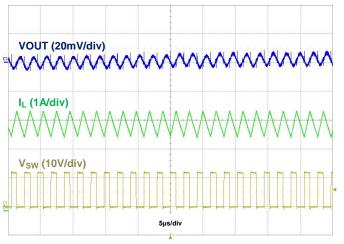


Figure 20. Output Voltage Ripple, IOUT = 3A

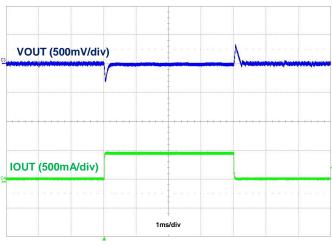


Figure 21. Load Transient, IOUT = 50mA to 500mA to 50mA

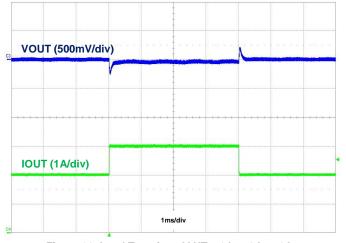


Figure 22. Load Transient, IOUT = 2A to 3A to 2A

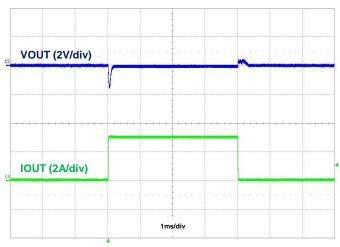
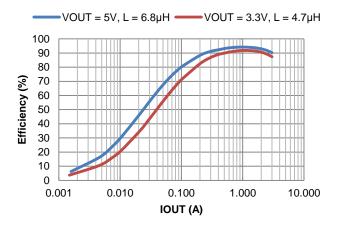


Figure 23. Load Transient, IOUT = 50mA to 3A to 50mA



# Typical Performance Characteristics (AP63301 at T<sub>A</sub> = +25°C, VIN = 12V, VOUT = 5V, unless otherwise specified.)



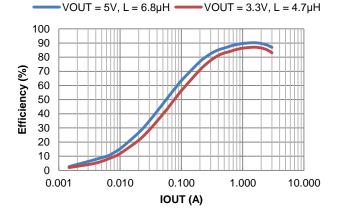
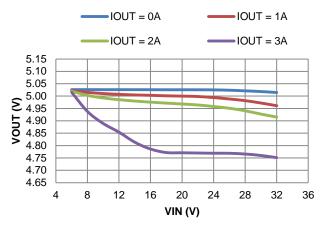


Figure 24. Efficiency vs. Output Current, VIN = 12V

Figure 25. Efficiency vs. Output Current, VIN = 24V



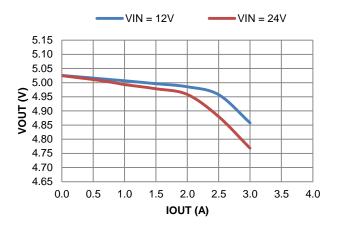
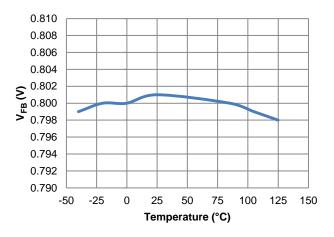


Figure 26. Line Regulation

Figure 27. Load Regulation



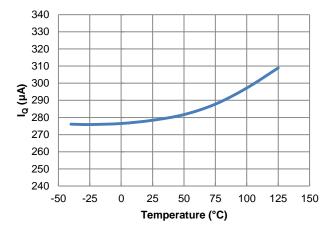
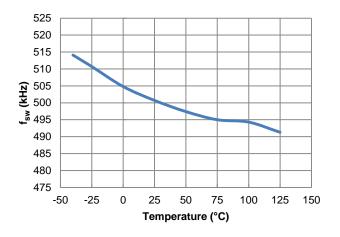


Figure 28. Feedback Voltage vs. Temperature

Figure 29. IQ vs. Temperature



# **Typical Performance Characteristics** (AP63301 at T<sub>A</sub> = +25°C, VIN = 12V, VOUT = 5V, unless otherwise specified.) (continued)



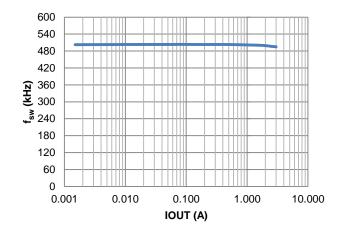
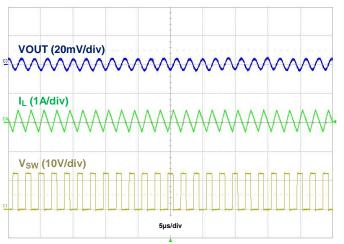


Figure 30. f<sub>sw</sub> vs. Temperature, IOUT = 0A





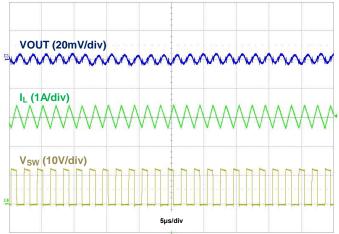


Figure 32. Output Voltage Ripple, IOUT = 50mA

Figure 33. Output Voltage Ripple, IOUT = 3A



# Typical Performance Characteristics (AP63301 at T<sub>A</sub> = +25°C, VIN = 12V, VOUT = 5V, unless otherwise specified.) (cont.)

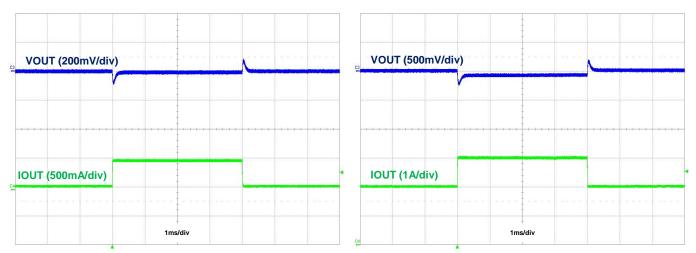


Figure 34. Load Transient, IOUT = 50mA to 500mA to 50mA

Figure 35. Load Transient, IOUT = 2A to 3A to 2A

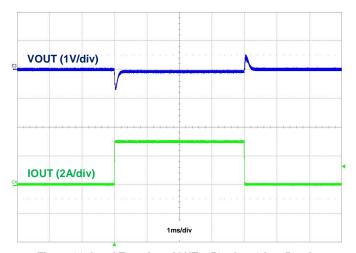


Figure 36. Load Transient, IOUT = 50mA to 3A to 50mA



## **Application Information**

#### 1 Pulse Width Modulation (PWM) Operation

The AP63300/AP63301 device is a 3.8V-to-32V input, 3A output, EMI friendly, fully integrated synchronous buck converter. Refer to the block diagram in Figure 4. The device employs fixed-frequency peak current mode control. The internal 500kHz clock's rising edge initiates turning on the integrated high-side power MOSFET, Q1, for each cycle. When Q1 is on, the inductor current rises linearly and the device charges the output capacitor. The current across Q1 is sensed and converted to a voltage with a ratio of  $R_T$  via the CSA block. The CSA output is combined with an internal slope compensation,  $S_E$ , resulting in  $V_{SUM}$ . When  $V_{SUM}$  rises higher than the COMP node, the device turns off Q1 and turns on the low-side power MOSFET, Q2. The inductor current decreases when Q2 is on. On the rising edge of next clock cycle, Q2 turns off and Q1 turns on. This sequence repeats every clock cycle.

The error amplifier generates the COMP voltage by comparing the voltage on the FB pin with an internal 0.8V reference. An increase in load current causes the feedback voltage to drop. The error amplifier thus raises the COMP voltage until the average inductor current matches the increased load current. This feedback loop regulates the output voltage. The internal slope compensation circuitry prevents subharmonic oscillation when the duty cycle is greater than 50% for peak current mode control.

The peak current mode control, integrated loop compensation network, and built-in 4ms soft-start time simplifies the AP63300/AP63301 footprint as well as minimizes the external component count.

In order to provide a small output ripple during light load conditions, the AP63301 operates in PWM regardless of output load.

#### 2 Pulse Frequency Modulation (PFM) Operation

In heavy load conditions, the AP63300 operates in forced PWM mode. As the load current decreases, the internal COMP node voltage also decreases. At a certain limit, if the load current is low enough, the COMP node voltage is clamped and is prevented from decreasing any further. The voltage at which COMP is clamped corresponds to the 930mA PFM peak inductor current limit. As the load current approaches zero, the AP63300 enters PFM mode to increase the converter power efficiency at light load conditions. When the inductor current decreases to 60mA, zero cross detection circuitry on the low-side power MOSFET, Q2, forces it off. The buck converter does not sink current from the output when the output load is light and while the device is in PFM. Because the AP63300 works in PFM during light load conditions, it can achieve power efficiency of up to 88% at a 5mA load condition.

The quiescent current of AP63300 is 22µA typical under a no-load, non-switching condition.

#### 3 Enable

When disabled, the device shutdown supply current is only  $1\mu$ A. When applying a voltage greater than the EN logic high threshold (typical 1.18V, rising), the AP63300/AP63301 enables all functions and the device initiates the soft-start phase. The EN pin is a high-voltage pin and can be directly connected to VIN to automatically start up the device as VIN increases. An internal 1.5 $\mu$ A pull-up current source connected from the internal LDO-regulated VCC to the EN pin guarantees that if EN is left floating, the device still automatically enables once the voltage reaches the EN logic high threshold. The AP63300/AP63301 has a built-in 4ms soft-start time to prevent output voltage overshoot and inrush current. When the EN voltage falls below its logic low threshold (typical 1.09V, falling), the internal SS voltage discharges to ground and device operation disables.

The EN pin can also be used to program the undervoltage lockout thresholds. See Undervoltage Lockout (UVLO) section for more details.

Alternatively, a small ceramic capacitor can be added from EN to GND. This delays the triggering of EN, which delays the startup of the output voltage. This is useful when sequencing multiple power rails to minimize input inrush current. The amount of capacitance is calculated by:

$$C_{d}[nF] = 1.27 \cdot t_{d}[ms]$$
 Eq. 1

#### Where:

- C<sub>d</sub> is the time delay capacitance in nF
- t<sub>d</sub> is the delay time in ms



## **Application Information** (continued)

#### 4 Electromagnetic Interference (EMI) Reduction with Ringing-Free Switching Node and Frequency Spread Spectrum (FSS)

In some applications, the system must meet EMI standards. In relation to high frequency radiation EMI noise, the switching node's (SW's) ringing amplitude is especially critical. To dampen high frequency radiated EMI noise, the AP63300/AP63301 device implements a proprietary, multi-level gate driver scheme that achieves a ringing-free switching node without sacrificing the switching node's rise and fall slew rates as well as the converter's power efficiency.

To further improve EMI reduction, the AP63300 device also implements FSS with a switching frequency jitter of ±6%. FSS reduces conducted and radiated interference at a particular frequency by spreading the switching noise over a wider frequency band and by not allowing emitted energy to stay in any one frequency for a significant period of time.

#### 5 Adjusting Undervoltage Lockout (UVLO)

Undervoltage lockout is implemented to prevent the IC from insufficient input voltages. The AP63300/AP63301 device has a UVLO comparator that monitors the input voltage and the internal bandgap reference. The AP63300/AP63301 disables if the input voltage falls below 3.06V. In this UVLO event, both the high-side and low-side power MOSFETs turn off.

For applications requiring higher VIN UVLO threshold voltages than is provided by the default setup, a 4µA hysteresis pull-up current source on the EN pin along with an external resistive divider (R3 and R4) configures the VIN UVLO threshold voltages as shown in Figure 37.

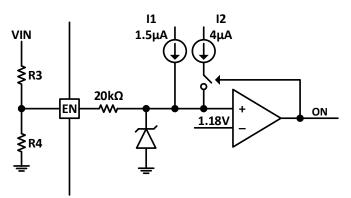


Figure 37. Programming UVLO

The resistive divider resistor values are calculated by:

$$R3 = \frac{0.924 \cdot V_{ON} - V_{OFF}}{4.114 \mu A} \label{eq:R3}$$
 Eq. 2

$$R4 = \frac{1.09 \cdot R3}{V_{OFF} - 1.09V + 5.5 \mu A \cdot R3} \label{eq:R4}$$
 Eq. 3

#### Where:

- V<sub>ON</sub> is the rising edge VIN voltage to enable the regulator and is greater than 3.7V
- V<sub>OFF</sub> is the falling edge VIN voltage to disable the regulator and is greater than 3.26V

#### 6 Output Overvoltage Protection (OVP)

The AP63300/AP63301 implements output OVP circuitry to minimize output voltage overshoots during decreasing load transients. The high-side power MOSFET turns off and the low-side power MOSFET turns on when the output voltage exceeds its target value by 10% in order to prevent the output voltage from continuing to increase.



## **Application Information (cont.)**

#### 7 Overcurrent Protection (OCP)

The AP63300/AP63301 has cycle-by-cycle peak current limit protection by sensing the current through the internal high-side power MOSFET, Q1. While Q1 is on, the internal sensing circuitry monitors its conduction current. Once the current through Q1 exceeds the peak current limit, Q1 immediately turns off. If Q1 consistently hits the peak current limit for 512 cycles, the buck converter enters hiccup mode and shuts down. After 8192 cycles of down time, the buck converter restarts powering up. Hiccup mode reduces the power dissipation in the overcurrent condition.

#### 8 Thermal Shutdown (TSD)

If the junction temperature of the device reaches the thermal shutdown limit of 160°C, the AP63300/AP63301 shuts down both its high-side and low-side power MOSFETs. When the junction temperature reduces to the required level (135°C typical), the device initiates a normal power-up cycle with soft-start.

#### 9 Power Derating Characteristics

To prevent the regulator from exceeding the maximum recommended operating junction temperature, some thermal analysis is required. The regulator's temperature rise is given by:

$$T_{RISE} = PD \cdot (\theta_{IA})$$
 Eq. 4

#### Where:

- PD is the power dissipated by the regulator
- θ<sub>JA</sub> is the thermal resistance from the junction of the die to the ambient temperature

The junction temperature, T<sub>J</sub>, is given by:

$$T_{I} = T_{A} + T_{RISE}$$
 Eq. 5

#### Where:

T<sub>A</sub> is the ambient temperature of the environment

For the TSOT26 package, the  $\theta_{JA}$  is 89°C/W. The actual junction temperature should not exceed the maximum recommended operating junction temperature of 125°C when considering the thermal design. Figure 38 shows a typical derating curve versus ambient temperature.

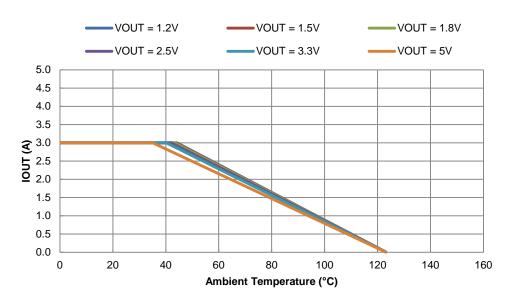


Figure 38. Output Current Derating Curve vs. Ambient Temperature, VIN = 12V



## **Application Information (cont.)**

#### 10 Setting the Output Voltage

The AP63300/AP63301 has adjustable output voltages starting from 0.8V using an external resistive divider. An optional external capacitor, C4 in Figure 1, of 10pF to 220pF improves the transient response. The resistor values of the feedback network are selected based on a design trade-off between efficiency and output voltage accuracy. There is less current consumption in the feedback network for high resistor values, which improves efficiency at light loads. However, values too high cause the device to be more susceptible to noise affecting its output voltage accuracy. R1 can be determined by the following equation:

$$R1 = R2 \cdot \left(\frac{VOUT}{0.8V} - 1\right)$$
 Eq. 6

Table 1 shows a list of recommended component selections for common AP63300/AP63301 output voltages referencing Figure 1.

AP63300/AP63301 Output Voltage R1 R2 C1 C2 C3 C.4 L (V)  $(k\Omega)$  $(k\Omega)$ (µH) (µF) (µF) (nF) (pF) 1.2 15.0 30.1 2.2 10 3 x 22 100 **OPEN** 1.5 26.1 10 3 x 22 100 OPEN 30.1 3.3 37.4 100 OPEN 1.8 30.1 3.3 10 2 x 22 2.5 63.4 30.1 4.7 10 2 x 22 100 56 3.3 93.1 30.1 4.7 10 2 x 22 100 56 5.0 158.0 30.1 6.8 10 2 x 22 100 47 2 x 22 12.0 422.0 30.1 10.0 10 100 12

**Table 1. Recommended Component Selections** 

#### 11 Inductor

Calculating the inductor value is a critical factor in designing a buck converter. For most designs, the following equation can be used to calculate the inductor value:

$$L = \frac{VOUT \cdot (VIN - VOUT)}{VIN \cdot \Delta I_I \cdot f_{sw}}$$
 Eq. 7

Where:

- Δl<sub>L</sub> is the inductor current ripple
- f<sub>SW</sub> is the buck converter switching frequency

For AP63300/AP63301, choose  $\Delta I_L$  to be 30% to 50% of the maximum load current of 3A.

The inductor peak current is calculated by:

$$I_{\mathrm{L_{PEAK}}} = I_{\mathrm{LOAD}} + \frac{\Delta I_{\mathrm{L}}}{2}$$
 Eq. 8

Peak current determines the required saturation current rating, which influences the size of the inductor. Saturating the inductor decreases the converter efficiency while increasing the temperatures of the inductor and the internal power MOSFETs. Therefore, choosing an inductor with the appropriate saturation current rating is important. For most applications, it is recommended to select an inductor of approximately  $2.2\mu$ H to  $10\mu$ H with a DC current rating of at least 35% higher than the maximum load current. For highest efficiency, the inductor's DC resistance should be less than  $30m\Omega$ . Use a larger inductance for improved efficiency under light load conditions.



## **Application Information (cont.)**

#### 12 Input Capacitor

The input capacitor reduces both the surge current drawn from the input supply as well as the switching noise from the device. The input capacitor must sustain the ripple current produced during the on-time of Q1. It must have a low ESR to minimize power dissipation due to the RMS input current.

The RMS current rating of the input capacitor is a critical parameter and must be higher than the RMS input current. As a rule of thumb, select an input capacitor with an RMS current rating greater than half of the maximum load current.

Due to large dl/dt through the input capacitor, electrolytic or ceramic capacitors with low ESR should be used. If using a tantalum capacitor, it must be surge protected or else capacitor failure could occur. Using a ceramic capacitor greater than 10µF is sufficient for most applications.

#### 13 Output Capacitor

The output capacitor keeps the output voltage ripple small, ensures feedback loop stability, and reduces both the overshoots and undershoots of the output voltage during load transients. During the first few microseconds of an increasing load transient, the converter recognizes the change from steady-state and enters 100% duty cycle to supply more current to the load. However, the inductor limits the change to increasing current depending on its inductance. Therefore, the output capacitor supplies the difference in current to the load during this time. Likewise, during the first few microseconds of a decreasing load transient, the converter recognizes the change from steady-state and sets the on-time to minimum to reduce the current supplied to the load. However, the inductor limits the change in decreasing current as well. Therefore, the output capacitor absorbs the excess current from the inductor during this time.

The effective output capacitance, COUT, requirements can be calculated from the equations below.

The ESR of the output capacitor dominates the output voltage ripple. The amount of ripple can be calculated by:

$$VOUT_{Ripple} = \Delta I_{L} \cdot \left(ESR + \frac{1}{8 \cdot f_{sw} \cdot COUT}\right)$$
 Eq. 9

An output capacitor with large capacitance and low ESR is the best option. For most applications, a 22µF to 68µF ceramic capacitor is sufficient. To meet the load transient requirements, the calculated COUT should satisfy the following inequality:

$$COUT > max \left( \frac{L \cdot I_{Trans}^2}{\Delta V_{Overshoot} \cdot VOUT}, \frac{L \cdot I_{Trans}^2}{\Delta V_{Undershoot} \cdot (VIN - VOUT)} \right)$$
 Eq. 10

#### Where:

- I<sub>Trans</sub> is the load transient
- ΔV<sub>Overshoot</sub> is the maximum output overshoot voltage
- ullet  $\Delta V_{Undershoot}$  is the maximum output undershoot voltage

#### 14 Bootstrap Capacitor and Low-Dropout (LDO) Operation

To ensure proper operation, a ceramic capacitor must be connected between the BST and SW pins. A 100nF ceramic capacitor is sufficient. If the bootstrap capacitor voltage falls below 2.3V, the boot undervoltage protection circuit turns Q2 on for 220ns to refresh the bootstrap capacitor and raise its voltage back above 2.85V. The bootstrap capacitor voltage threshold is always maintained to ensure enough driving capability for Q1. This operation may arise during long periods of no switching such as in PFM with light load conditions. Another event that requires the refreshing of the bootstrap capacitor is when the input voltage drops close to the output voltage. Under this condition, the regulator enters low-dropout mode by holding Q1 on for multiple clock cycles. To prevent the bootstrap capacitor from discharging, Q2 is forced to refresh. The effective duty cycle is approximately 100% so that it acts as an LDO to maintain the output voltage regulation.



### Layout

#### **PCB Layout**

- The AP63300/AP63301 works at 3A load current so heat dissipation is a major concern in the layout of the PCB. 2oz copper for both the top and bottom layers is recommended.
- 2. Place the input capacitors as closely across VIN and GND as possible.
- 3. Place the inductor as close to SW as possible.
- 4. Place the output capacitors as close to GND as possible.
- 5. Place the feedback components as close to FB as possible.
- 6. If using four or more layers, use at least the 2<sup>nd</sup> and 3<sup>rd</sup> layers as GND to maximize thermal performance.
- 7. Add as many vias as possible around both the GND pin and under the GND plane for heat dissipation to all the GND layers.
- 8. Add as many vias as possible around both the VIN pin and under the VIN plane for heat dissipation to all the VIN layers.
- 9. See Figure 39 for more details.

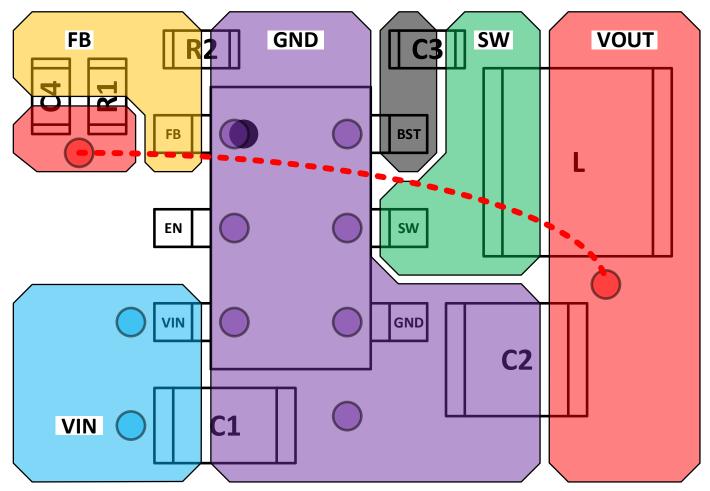
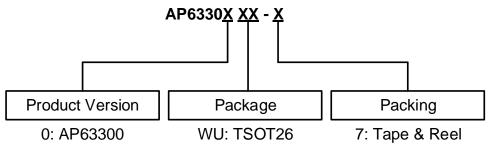


Figure 39. Recommended PCB Layout



# **Ordering Information**

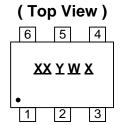


1	:	AP	6330	1

Part Number	Operation Mode	FSS Feature	Package Code	Tape and Reel		
I all Number	Operation widge			Quantity	Part Number Suffix	
AP63300WU-7	PFM/PWM	Yes	WU	3000	-7	
AP63301WU-7	PWM Only	No	WU	3000	-7	

# **Marking Information**

#### TSOT26



XX: Identification Code

<u>Y</u> : Year 0~9

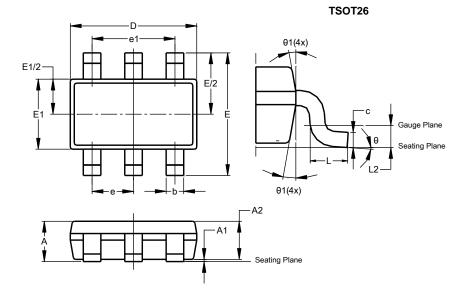
W : Week : A~Z : 1~26 week; a~z : 27~52 week; z represents 52 and 53 week X : Internal Code

Part Number	Package	Identification Code
AP63300WU-7	TSOT26	T6
AP63301WU-7	TSOT26	T7



# **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

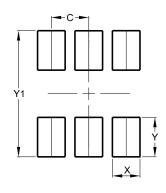


TSOT26					
Dim	Min	Max	Тур		
Α	_	1.00	_		
A1	0.010	0.100	_		
A2	0.840	0.900	_		
D	2.800	3.000	2.900		
Е	2	.800 BS	O		
E1	1.500	1.700	1.600		
b	0.300	0.450	_		
С	0.120	0.200	_		
е	0	.950 BS	O		
e1	1	.900 BS	O		
L	0.30	0.50	_		
L2	0	.250 BS	С		
θ	0°	8°	4°		
θ1	4° 12°		_		
All Dimensions in mm					

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

#### TSOT26



Dimensions	Value (in mm)
С	0.950
Х	0.700
Y	1.000
Y1	3.199



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